Search Notes					

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/612,011	JENTSCH ET AL.	
Examiner	Art Unit	
Hoang-Vu A. Nguyen-Ba	2192	

SEARCHED				
Class	Subclass	Date	Examiner	
,				

INTERFERENCE SEARCHED		
Subclass	Date	Examiner
	<u> </u>	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
Inventor name Search	4/20/2006	HAN
East Search (USPAT, US-PGPUB, EPO, JPO, DERWENT, IBM-TDB) See Search History Printout	4/20/2006	HAN
717/124-135; 712/226-227, 244; 714/34-35, 38 - text search only	4/20/2006	HAN
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